

TOSHIBA Field Effect Transistor Silicon P, N Channel MOS Type
(P Channel U-MOSII/N Channel U-MOSII)

TPC8403

Motor Dreive
Notebook PC
Portable Machines and Tools

- Low drain-source ON resistance: P Channel $R_{DS(ON)} = 45 \text{ m}\Omega$ (typ.)
N Channel $R_{DS(ON)} = 25 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: P Channel $|Y_{fs}| = 6.2 \text{ S}$ (typ.)
N Channel $|Y_{fs}| = 7.8 \text{ S}$ (typ.)
- Low leakage current: P Channel $I_{DSS} = -10 \text{ }\mu\text{A}$ ($V_{DS} = -30 \text{ V}$)
N Channel $I_{DSS} = 10 \text{ }\mu\text{A}$ ($V_{DS} = 30 \text{ V}$)
- Enhancement-mode
: P Channel $V_{th} = -1.0 \sim -2.2 \text{ V}$ ($V_{DS} = -10 \text{ V}$, $I_D = -1 \text{ mA}$)
: N Channel $V_{th} = 1.3 \sim 2.5 \text{ V}$ ($V_{DS} = 10 \text{ V}$, $I_D = 1 \text{ mA}$)

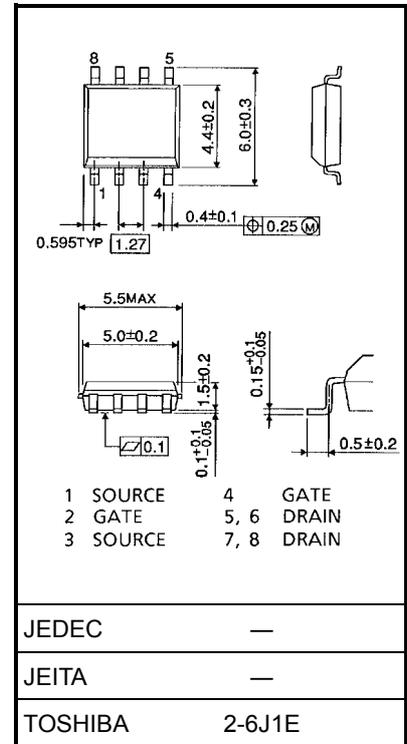
Maximum Ratings ($T_a = 25^\circ\text{C}$)

Characteristics		Symbol	Rating		Unit
			P Channel	N Channel	
Drain-source voltage		V_{DSS}	-30	30	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V_{DGR}	-30	30	V
Gate-source voltage		V_{GSS}	± 20	± 20	V
Drain current	DC (Note 1)	I_D	-4.5	6	A
	Pulse (Note 1)	I_{DP}	-18	24	
Drain power dissipation ($t = 10\text{s}$) (Note 2a)	Single-device operation (Note 3a)	$P_{D(1)}$	1.5	1.5	W
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	1.1	1.1	
Drain power dissipation ($t = 10\text{s}$) (Note 2b)	Single-device operation (Note 3a)	$P_{D(1)}$	0.75	0.75	
	Single-device value at dual operation (Note 3b)	$P_{D(2)}$	0.45	0.45	
Single pulse avalanche energy		E_{AS}	26.3 (Note 4a)	46.8 (Note 4b)	mJ
Avalanche current		I_{AR}	-4.5	6	A
Repetitive avalanche energy Single-device value at operation (Note 2a, 3b, 5)		E_{AR}	0.11		mJ
Channel temperature		T_{ch}	150		$^\circ\text{C}$
Storage temperature range		T_{stg}	-55~150		$^\circ\text{C}$

Note: (Note 1), (Note 2ab), (Note 3ab), (Note 4), (Note 5) Please see next page.

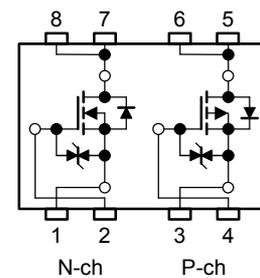
This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm



Weight: 0.080 g (typ.)

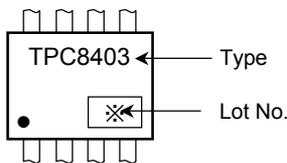
Circuit Configuration



Thermal Characteristics

Characteristics		Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10s)	Single-device operation (Note 3a)	R _{th (ch-a)} (1)	83.3	°C/W
	Single-device value at dual operation (Note 3b)	R _{th (ch-a)} (2)	114	
Thermal resistance, channel to ambient (t = 10s)	Single-device operation (Note 2a)	R _{th (ch-a)} (1)	167	
	Single-device value at dual operation (Note 2b)	R _{th (ch-a)} (2)	278	

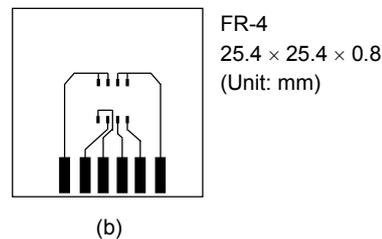
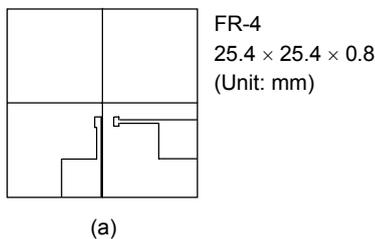
Marking



Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a) b) Device mounted on a glass-epoxy board (b)



Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

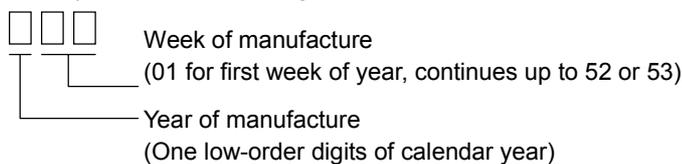
Note 4:

- a) $V_{DD} = -24\text{ V}$, $T_{ch} = 25^\circ\text{C}$ (Initial), $L = 1.0\text{ mH}$, $R_G = 25\ \Omega$, $I_{AR} = -4.5\text{ A}$
- b) $V_{DD} = 24\text{ V}$, $T_{ch} = 25^\circ\text{C}$ (Initial), $L = 1.0\text{ mH}$, $R_G = 25\ \Omega$, $I_{AR} = 6.0\text{ A}$

Note 5: Repetitive rating; pulse width limited by max channel temperature.

Note 6: • on lower left of the marking indicates Pin 1.

※ Weekly code: (Three digits)



P-ch

Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	—	—	± 10	μA
Drain cut-OFF current		I_{DSS}	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	—	—	-10	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30	—	—	V
		$V_{(BR)DSX}$	$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-15	—	—	
Gate threshold voltage		V_{th}	$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-1.0	—	-2.2	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = -4.5 \text{ V}, I_D = -2.2 \text{ A}$	—	66	90	m Ω
			$V_{GS} = -10 \text{ V}, I_D = -2.2 \text{ A}$	—	45	55	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = -10 \text{ V}, I_D = -2.2 \text{ A}$	3.1	6.2	—	S
Input capacitance		C_{iss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	—	940	—	pF
Reverse transfer capacitance		C_{rss}		—	270	—	
Output capacitance		C_{oss}		—	390	—	
Switching time	Rise time	t_r		—	13	—	ns
	Turn-ON time	t_{on}		—	21	—	
	Fall time	t_f		—	25	—	
	Turn-OFF time	t_{off}		Duty $\leq 1\%$, $t_w = 10 \mu\text{s}$	—	73	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx -24 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -4.5 \text{ A}$	—	18	—	nC
Gate-source charge 1		Q_{gs1}		—	4	—	
Gate-drain ("miller") charge		Q_{gd}		—	4	—	

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	-18	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = -4.5 \text{ A}, V_{GS} = 0 \text{ V}$	—	—	1.2	V

N-ch

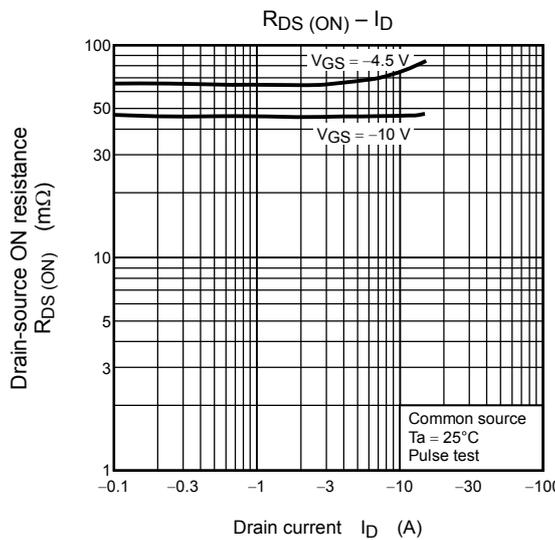
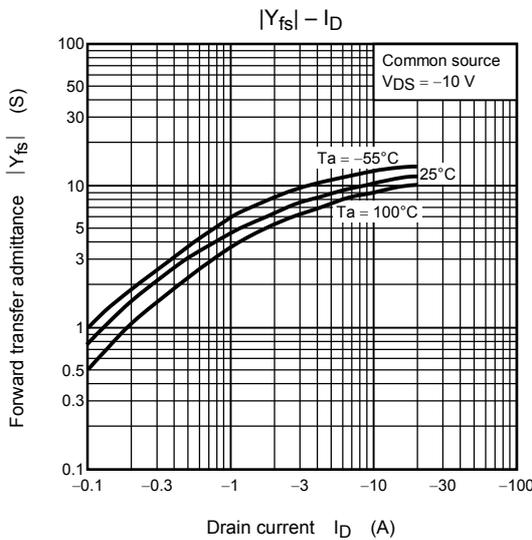
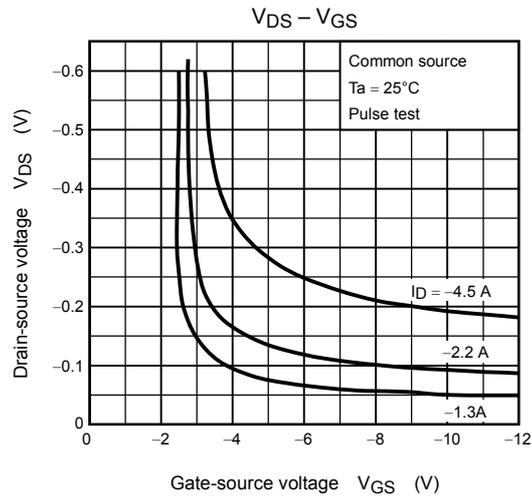
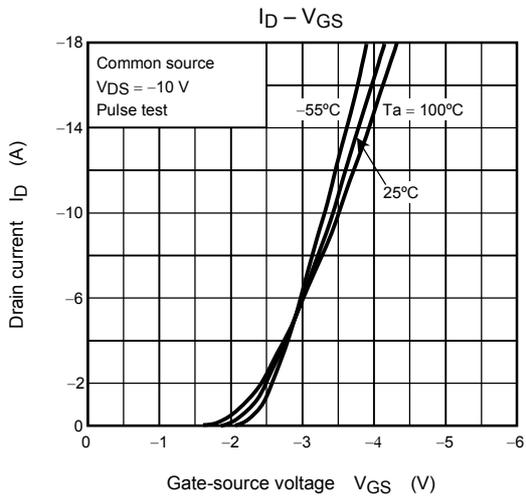
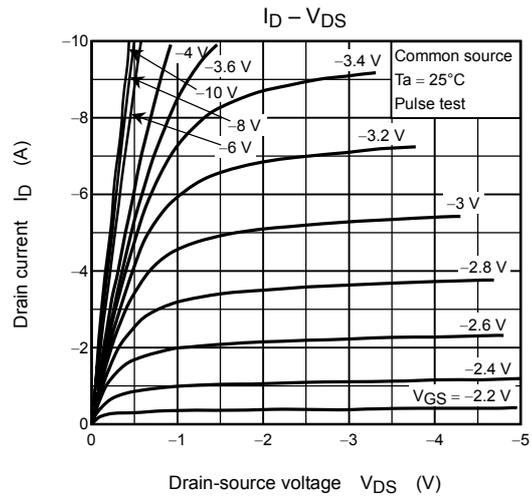
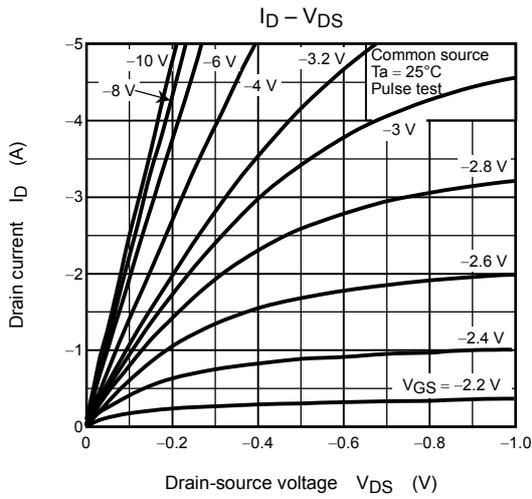
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GSS}	$V_{GS} = \pm 16\text{ V}, V_{DS} = 0\text{ V}$	—	—	± 10	μA
Drain cut-OFF current		I_{DSS}	$V_{DS} = 30\text{ V}, V_{GS} = 0\text{ V}$	—	—	10	μA
Drain-source breakdown voltage		$V_{(BR)DSS}$	$I_D = 10\text{ mA}, V_{GS} = 0\text{ V}$	30	—	—	V
		$V_{(BR)DSX}$	$I_D = 10\text{ mA}, V_{GS} = -20\text{ V}$	15	—	—	
Gate threshold voltage		V_{th}	$V_{DS} = 10\text{ V}, I_D = 1\text{ mA}$	1.3	—	2.5	V
Drain-source ON resistance		$R_{DS(ON)}$	$V_{GS} = 4.5\text{ V}, I_D = 3\text{ A}$	—	38	46	m Ω
			$V_{GS} = 10\text{ V}, I_D = 3\text{ A}$	—	25	33	
Forward transfer admittance		$ Y_{fs} $	$V_{DS} = 10\text{ V}, I_D = 3\text{ A}$	3.9	7.8	—	S
Input capacitance		C_{iss}	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	—	850	—	pF
Reverse transfer capacitance		C_{rss}		—	180	—	
Output capacitance		C_{oss}		—	270	—	
Switching time	Rise time	t_r		—	11	—	ns
	Turn-ON time	t_{on}		—	18	—	
	Fall time	t_f		—	6.5	—	
	Turn-OFF time	t_{off}		Duty $\leq 1\%$, $t_w = 10\ \mu\text{s}$	—	27	
Total gate charge (gate-source plus gate-drain)		Q_g	$V_{DD} \approx 24\text{ V}, V_{GS} = 10\text{ V}, I_D = 6\text{ A}$	—	17	—	nC
Gate-source charge 1		Q_{gs1}		—	3	—	
Gate-drain ("miller") charge		Q_{gd}		—	4	—	

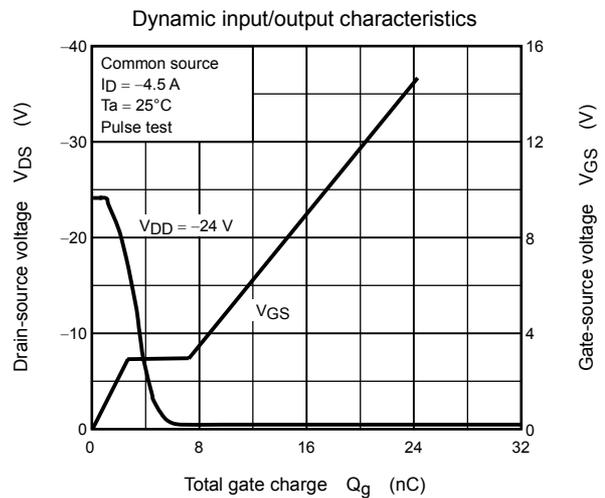
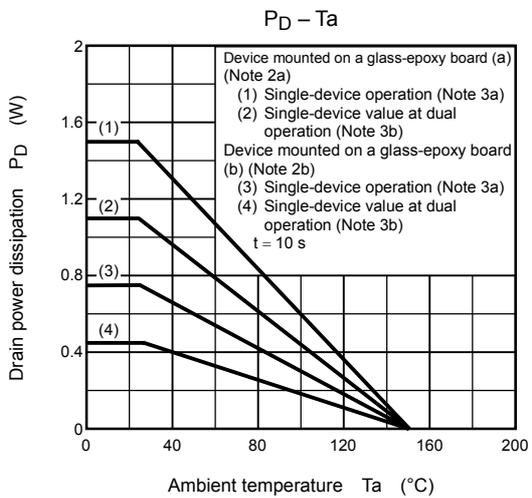
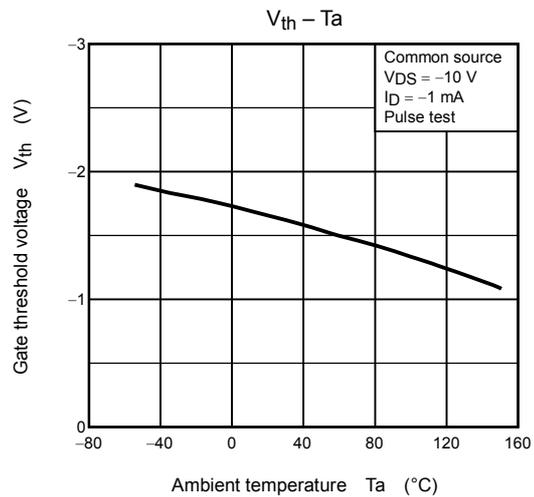
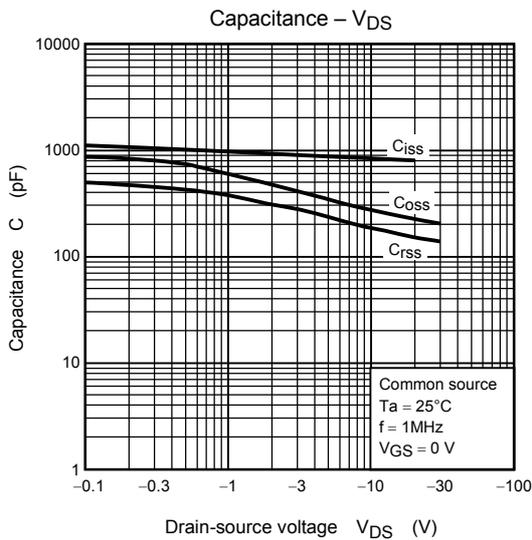
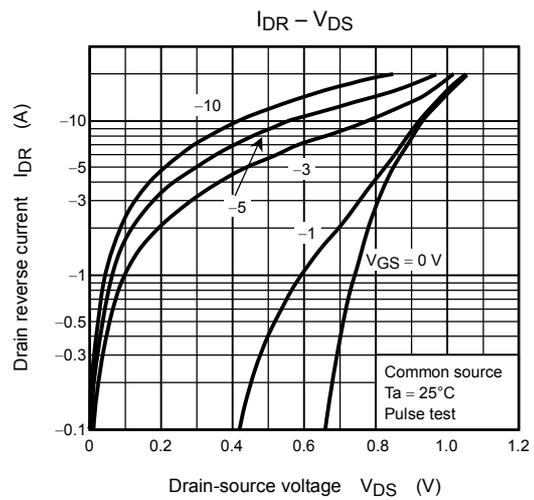
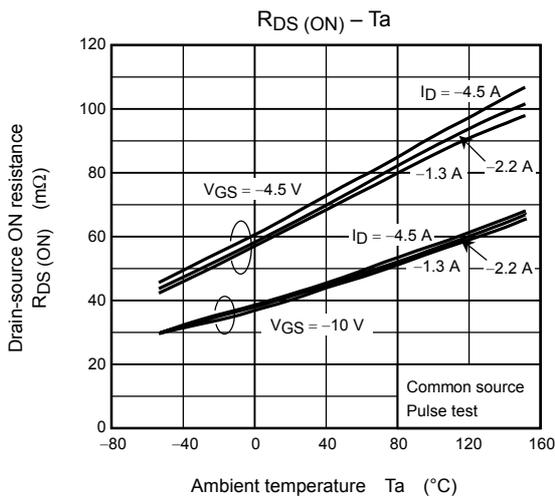
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Drain reverse current	Pulse (Note 1)	I_{DRP}	—	—	—	24	A
Forward voltage (diode)		V_{DSF}	$I_{DR} = 6\text{ A}, V_{GS} = 0\text{ V}$	—	—	-1.2	V

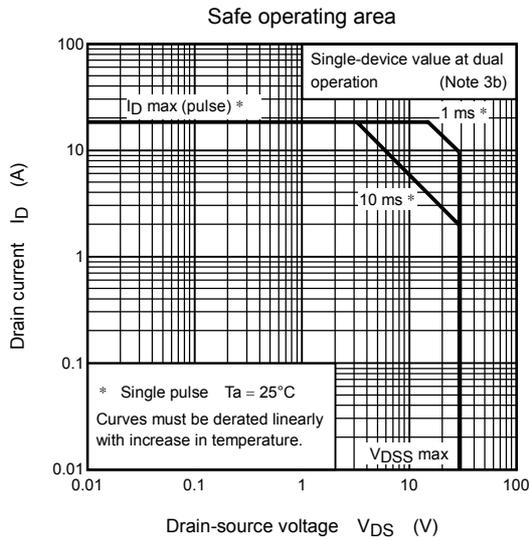
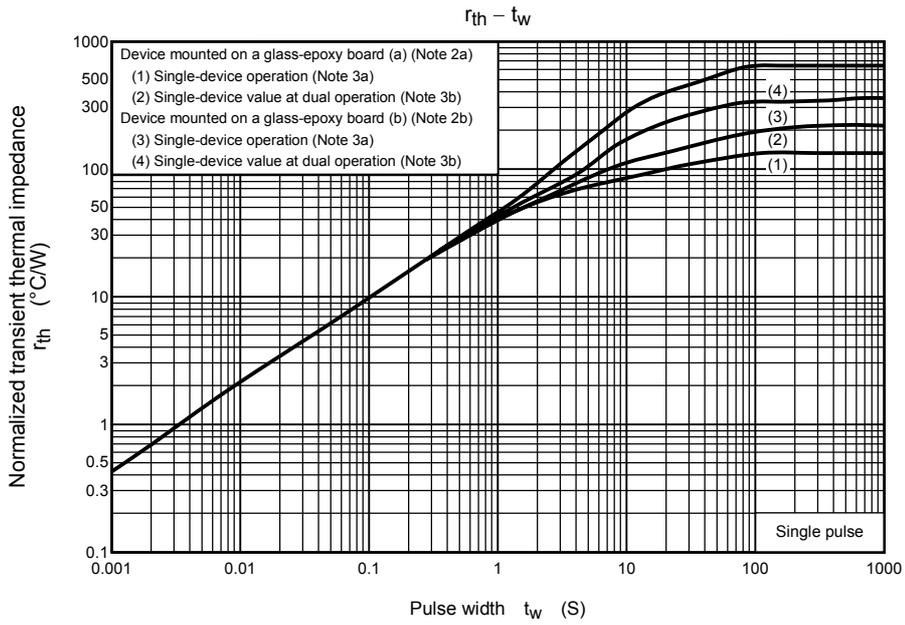
P-ch



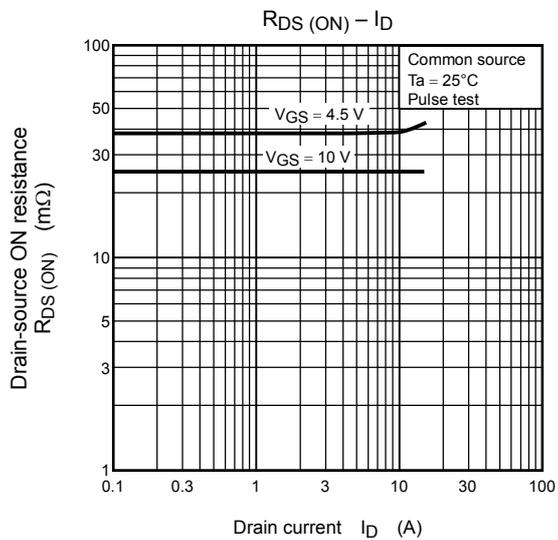
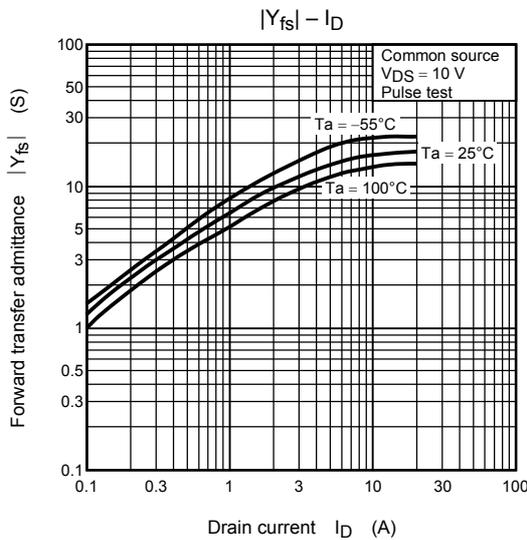
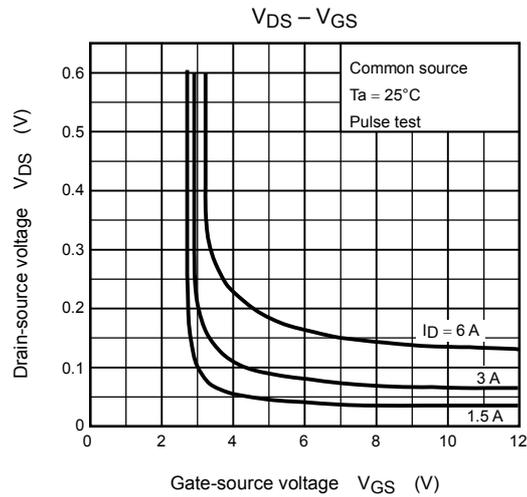
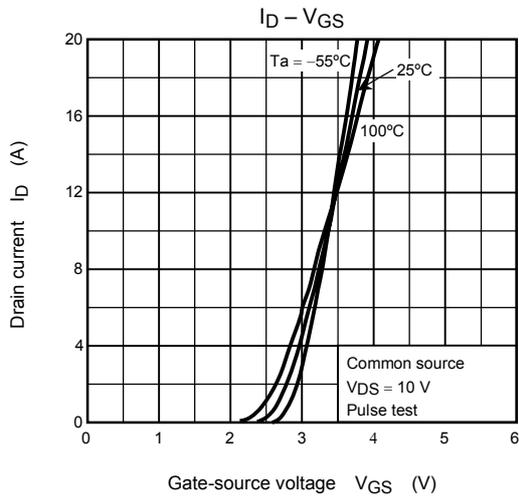
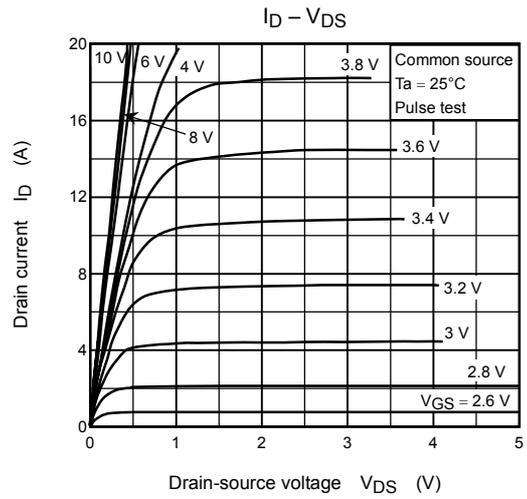
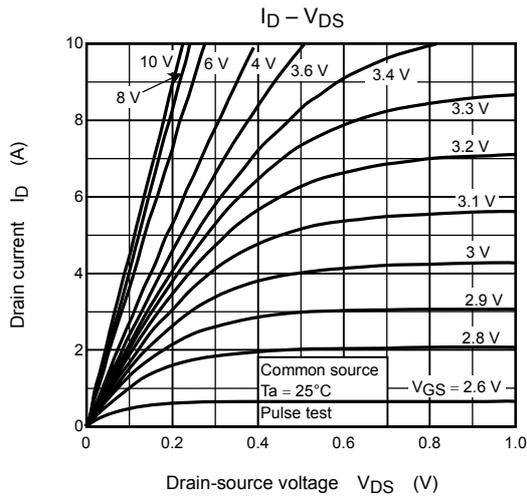
P-ch



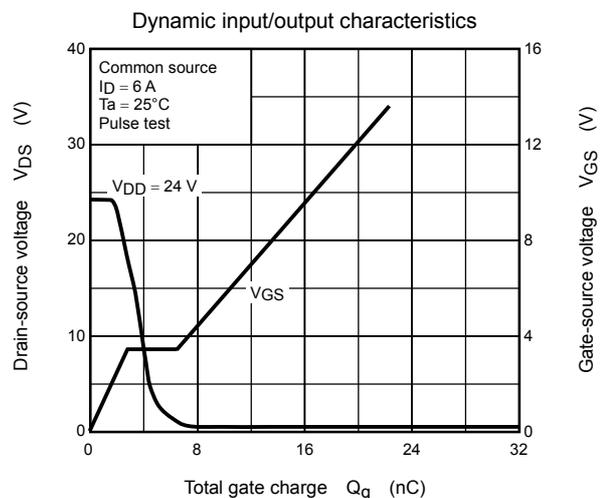
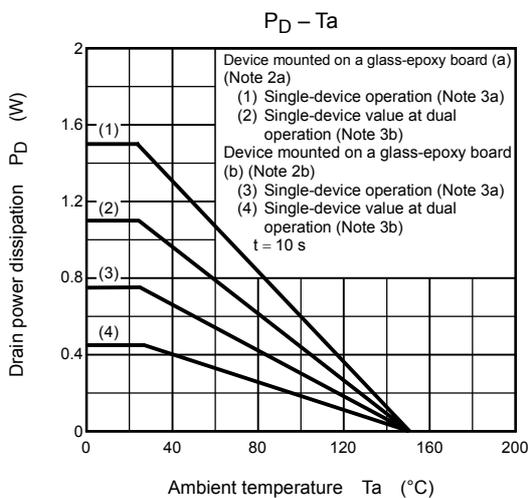
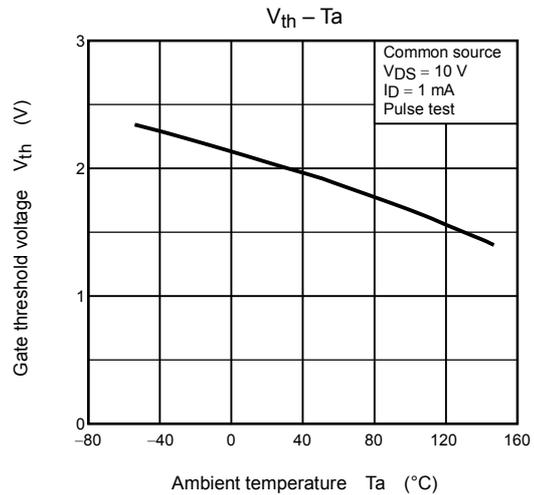
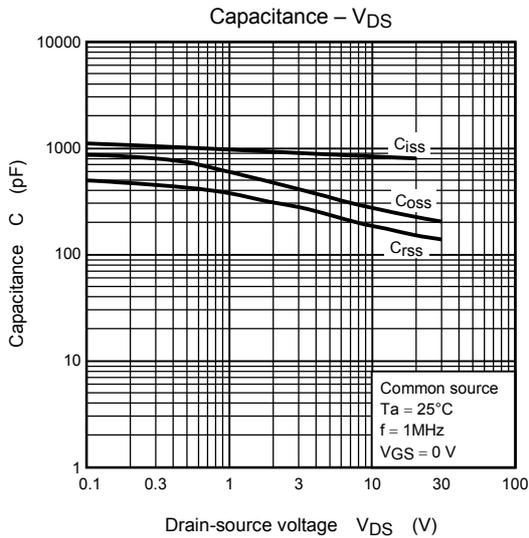
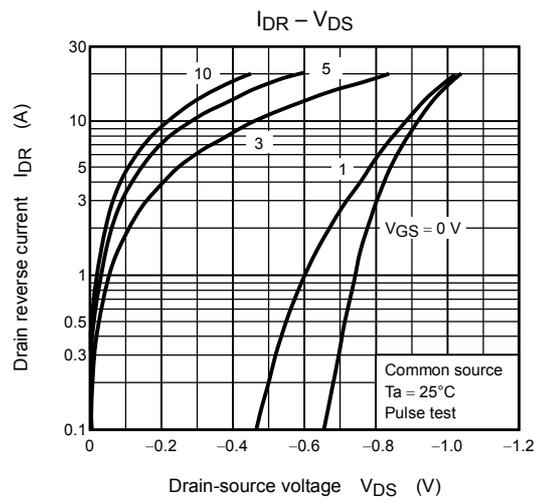
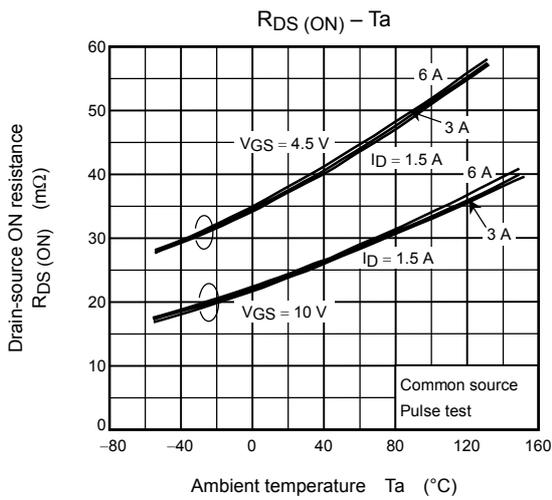
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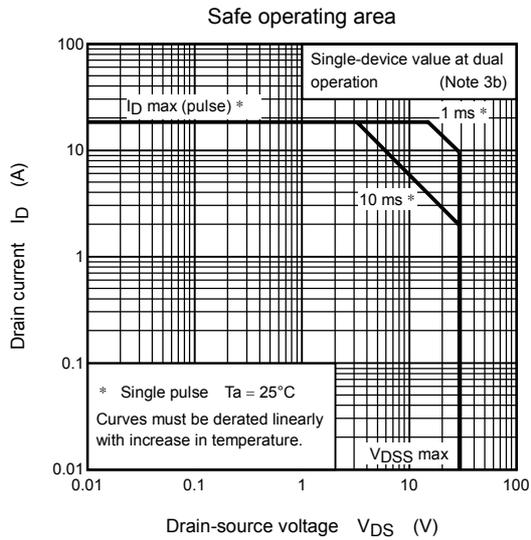
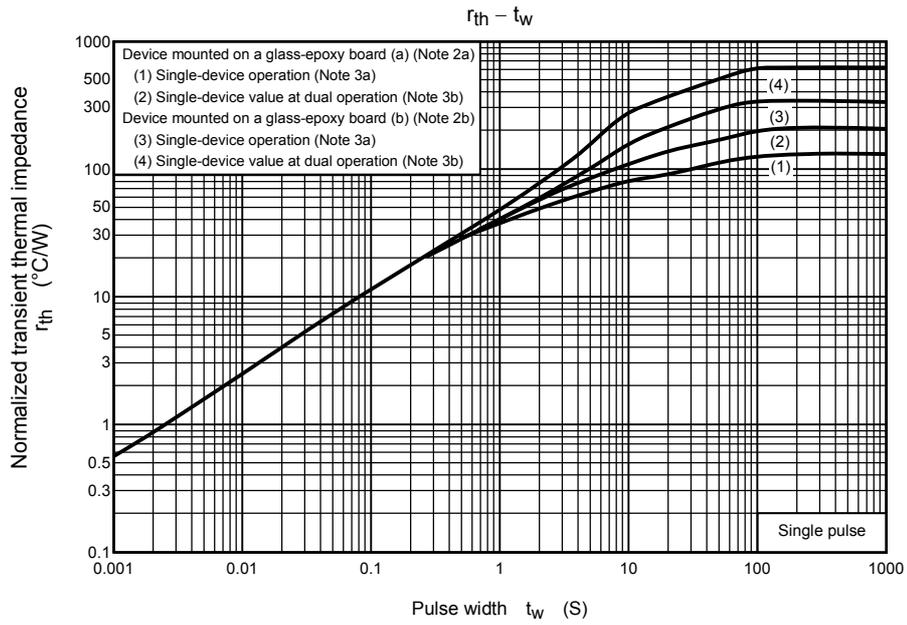
N-ch



N-ch



N-ch



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